

# NPN 8 GHz wideband transistors

# BFG67; BFG67/X; BFG67/XR

### FEATURES

- High power gain
- Low noise figure
- High transition frequency
- Gold metallization ensures excellent reliability.

### APPLICATIONS

Wideband applications in the GHz range, such as satellite TV tuners and portable RF communications equipment.

### DESCRIPTION

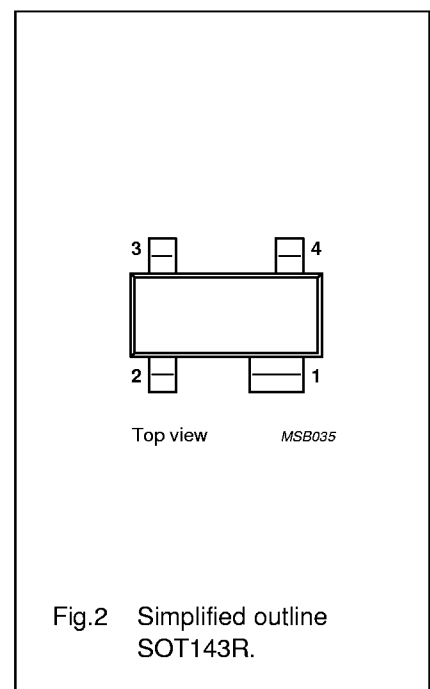
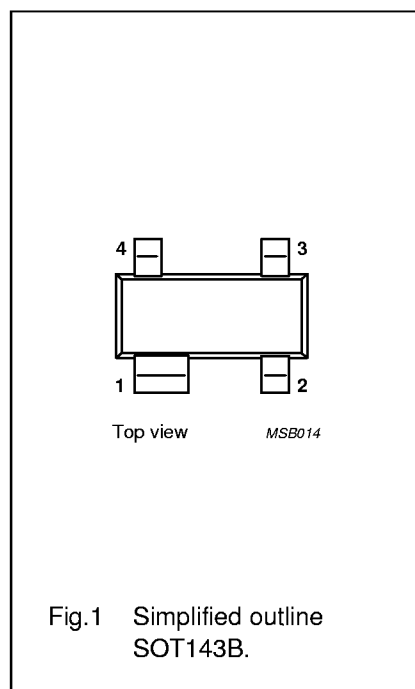
NPN silicon transistor in a 4-pin, dual-emitter SOT143B plastic package. Available with in-line emitter pinning (BFG67) and cross emitter pinning (BFG67/X). Version with reverse pinning (BFG67/XR) also available on request.

### MARKING

TYPE NUMBER	CODE
BFG67 (Fig.1)	V3
BFG67/X (Fig.1)	V12
BFG67/XR (Fig.2)	V26

### PINNING

PIN	DESCRIPTION		
	BFG67	BFG67/X	BFG67/XR
1	collector	collector	collector
2	base	emitter	emitter
3	emitter	base	base
4	emitter	emitter	emitter



### QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
$V_{CE0}$	collector-emitter voltage	open base	–	10	V
$I_C$	collector current (DC)		–	50	mA
$P_{tot}$	total power dissipation	$T_s \leq 65\text{ }^\circ\text{C}$	–	300	mW
$C_{re}$	feedback capacitance	$I_C = i_c = 0; V_{CB} = 8\text{ V}; f = 1\text{ MHz}$	0.5	–	pF
$f_T$	transition frequency	$I_C = 15\text{ mA}; V_{CE} = 8\text{ V}; f = 500\text{ MHz}$	8	–	GHz
$G_{UM}$	maximum unilateral power gain	$I_C = 15\text{ mA}; V_{CE} = 8\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}; f = 1\text{ GHz}$	17	–	dB
F	noise figure	$\Gamma_s = \Gamma_{opt}; I_C = 5\text{ mA}; V_{CE} = 8\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}; f = 1\text{ GHz}$	1.3	–	dB
		$\Gamma_s = \Gamma_{opt}; I_C = 5\text{ mA}; V_{CE} = 8\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}; f = 2\text{ GHz}$	2.2	–	dB

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**LIMITING VALUES**

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>CBO</sub>	collector-base voltage	open emitter	–	20	V
V <sub>CEO</sub>	collector-emitter voltage	open base	–	10	V
V <sub>EBO</sub>	emitter-base voltage	open collector	–	2.5	V
I <sub>C</sub>	collector current (DC)		–	50	mA
P <sub>tot</sub>	total power dissipation	T <sub>s</sub> ≤ 65 °C; see Fig.3; note 1	–	380	mW
T <sub>stg</sub>	storage temperature range		–65	150	°C
T <sub>j</sub>	junction temperature		–	175	°C

**Note**

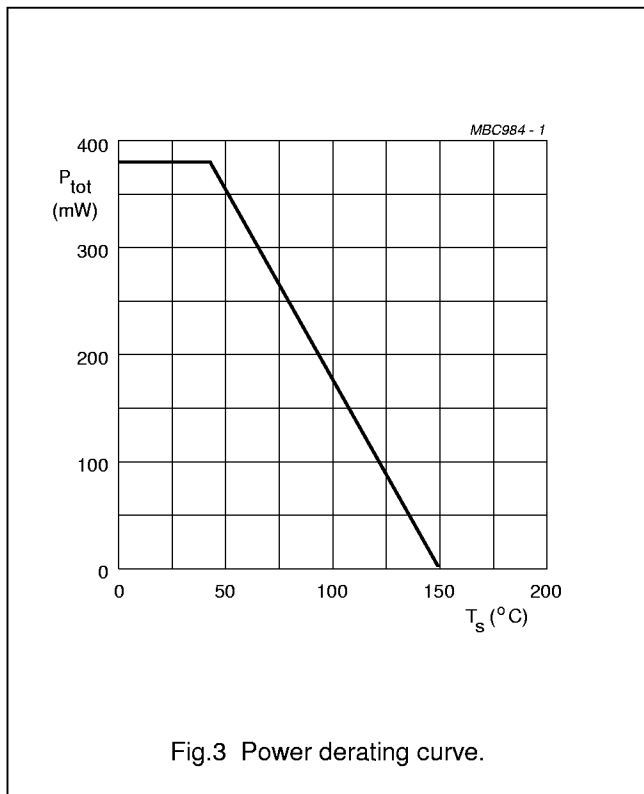
- 1. T<sub>s</sub> is the temperature at the soldering point of the collector pin.

**THERMAL CHARACTERISTICS**

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R <sub>th j-s</sub>	thermal resistance from junction to soldering point	note 1	290	K/W

**Note**

- 1. T<sub>s</sub> is the temperature at the soldering point of the collector pin.



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**CHARACTERISTICS**T<sub>j</sub> = 25 °C unless otherwise specified.

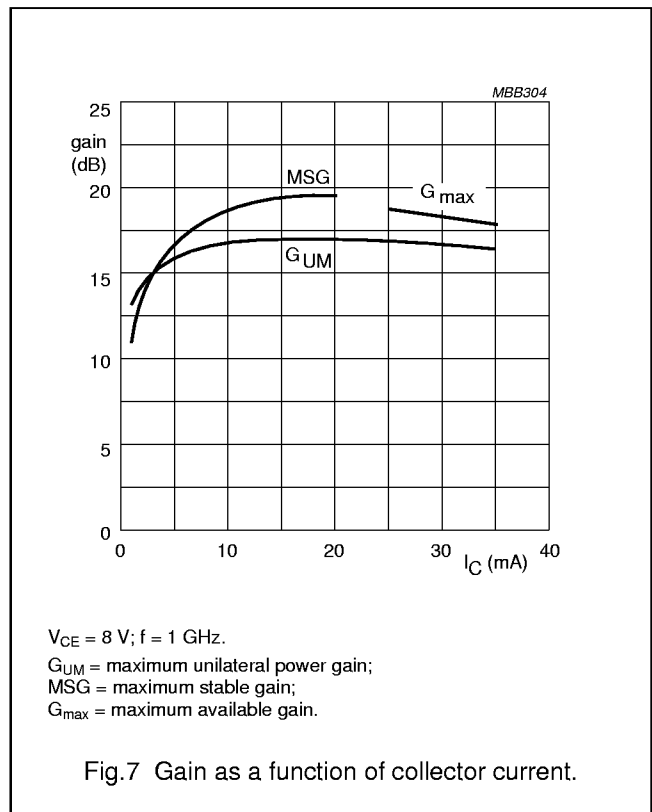
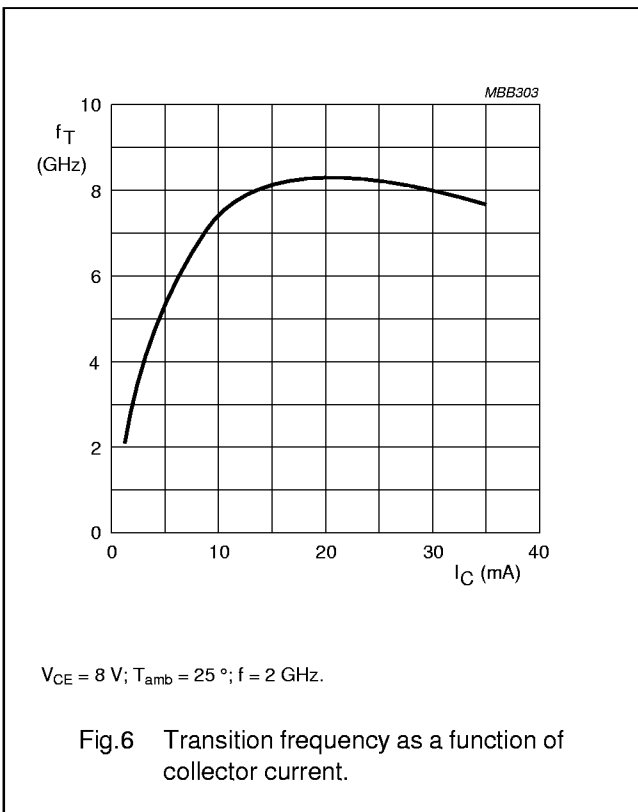
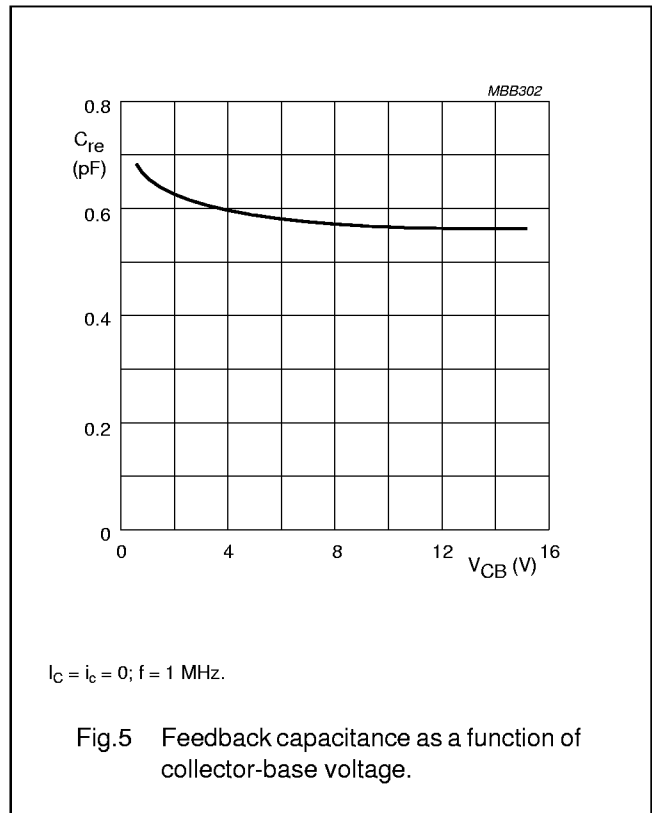
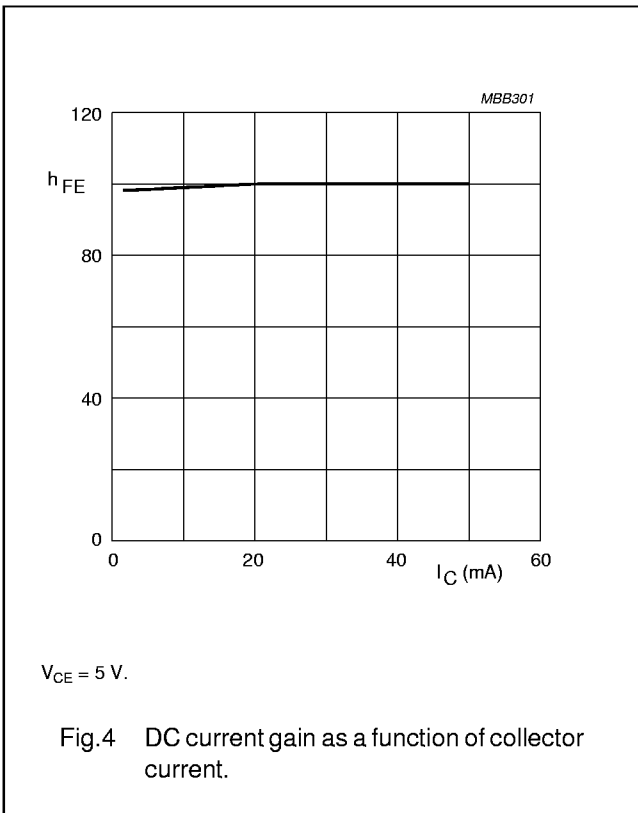
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I <sub>CBO</sub>	collector leakage current	V <sub>CB</sub> = 5 V; I <sub>E</sub> = 0	–	–	50	nA
h <sub>FE</sub>	DC current gain	I <sub>C</sub> = 15 mA; V <sub>CE</sub> = 5 V	60	100	–	
f <sub>T</sub>	transition frequency	I <sub>C</sub> = 15 mA; V <sub>CE</sub> = 8 V; f = 500 MHz	–	8	–	GHz
C <sub>c</sub>	collector capacitance	I <sub>E</sub> = I <sub>e</sub> = 0; V <sub>CB</sub> = 8 V; f = 1 MHz	–	0.7	–	pF
C <sub>e</sub>	emitter capacitance	I <sub>C</sub> = I <sub>c</sub> = 0; V <sub>EB</sub> = 0.5 V; f = 1 MHz	–	1.3	–	pF
C <sub>re</sub>	feedback capacitance	I <sub>C</sub> = I <sub>c</sub> = 0; V <sub>CB</sub> = 8 V; f = 1 MHz	–	0.5	–	pF
G <sub>UM</sub>	maximum unilateral power gain; note 1	I <sub>C</sub> = 15 mA; V <sub>CE</sub> = 8 V; T <sub>amb</sub> = 25 °C; f = 1 GHz	–	17	–	dB
		I <sub>C</sub> = 15 mA; V <sub>CE</sub> = 8 V; T <sub>amb</sub> = 25 °C; f = 2 GHz	–	10	–	dB
F	noise figure	Γ <sub>s</sub> = Γ <sub>opt</sub> ; I <sub>C</sub> = 5 mA; V <sub>CE</sub> = 8 V T <sub>amb</sub> = 25 °C; f = 1 GHz	–	1.3	–	dB
		Γ <sub>s</sub> = Γ <sub>opt</sub> ; I <sub>C</sub> = 15 mA; V <sub>CE</sub> = 8 V; T <sub>amb</sub> = 25 °C; f = 1 GHz	–	1.7	–	dB
		I <sub>C</sub> = 5 mA; V <sub>CE</sub> = 8 V; T <sub>amb</sub> = 25 °C; f = 2 GHz; Z <sub>S</sub> = 60 Ω	–	2.5	–	dB
		I <sub>C</sub> = 15 mA; V <sub>CE</sub> = 8 V; T <sub>amb</sub> = 25 °C; f = 2 GHz; Z <sub>S</sub> = 60 Ω	–	3	–	dB

**Note**

1. G<sub>UM</sub> is the maximum unilateral power gain, assuming S<sub>12</sub> is zero and  $G_{UM} = 10 \log \frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)}$  dB.

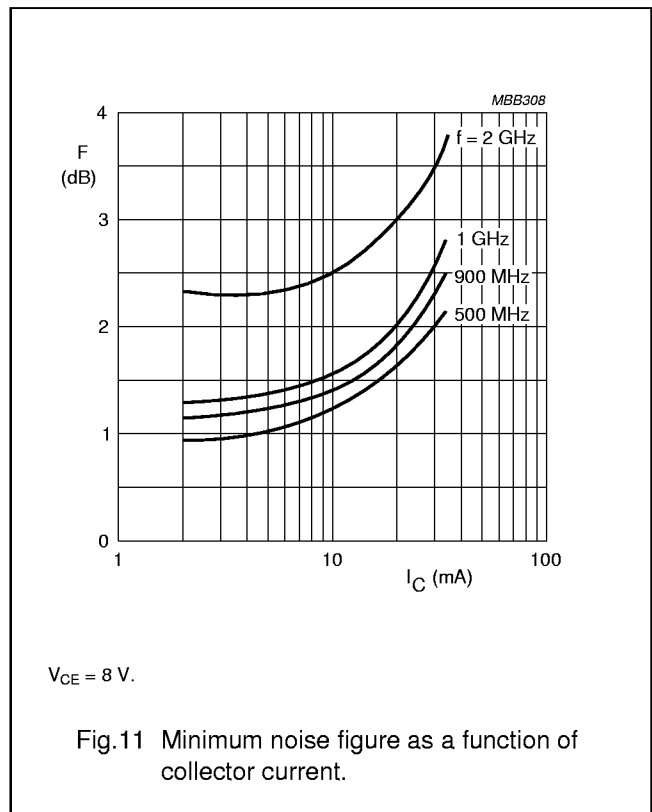
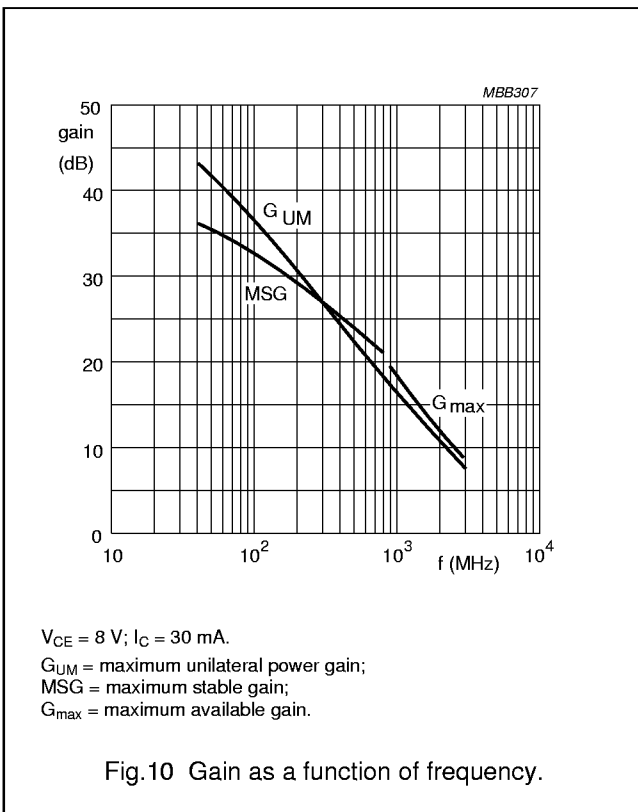
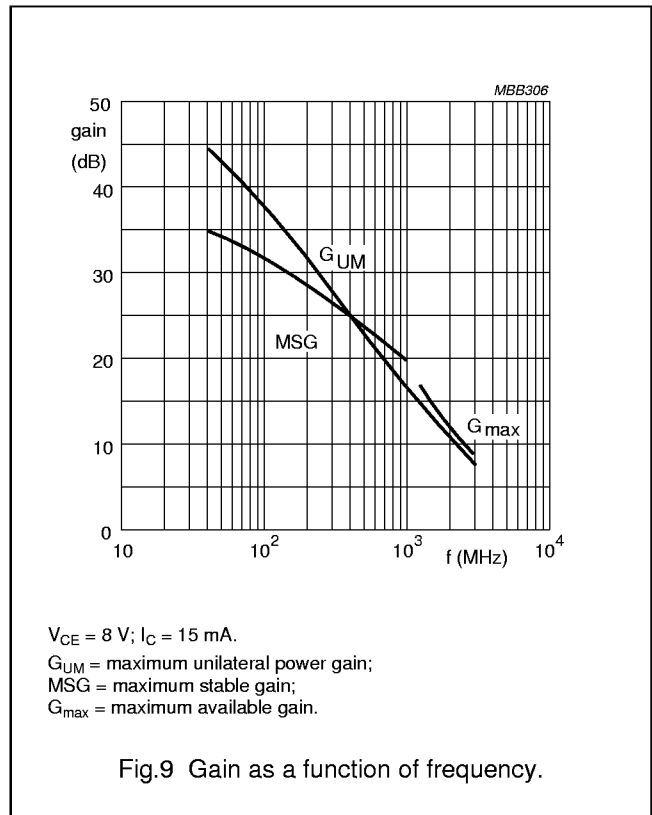
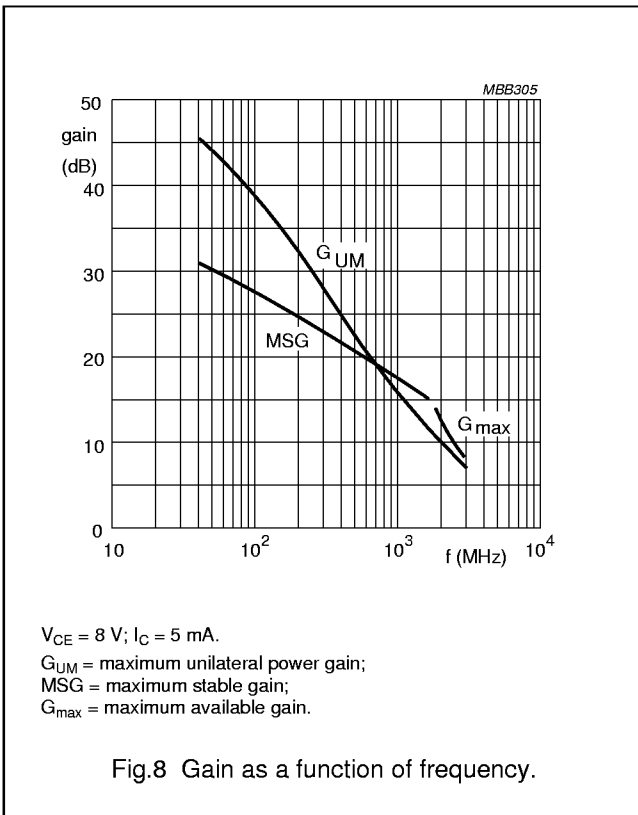
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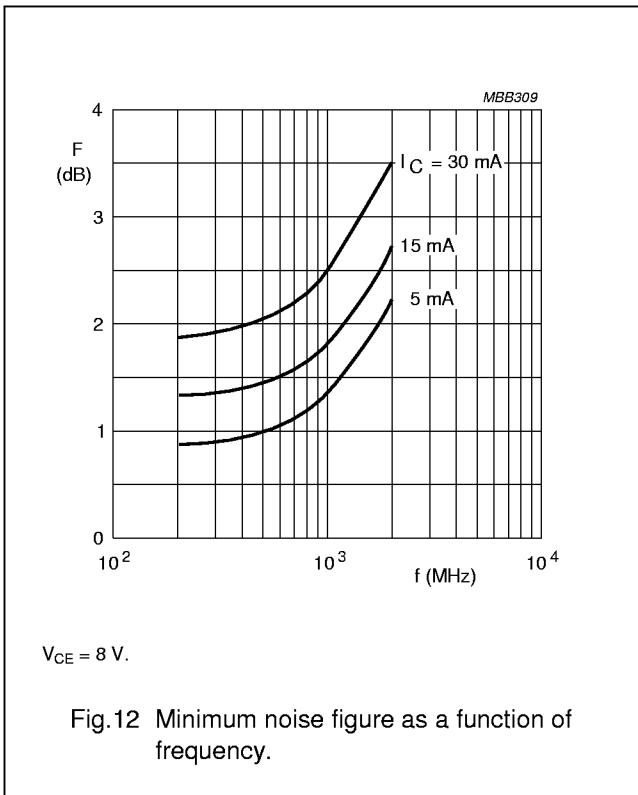
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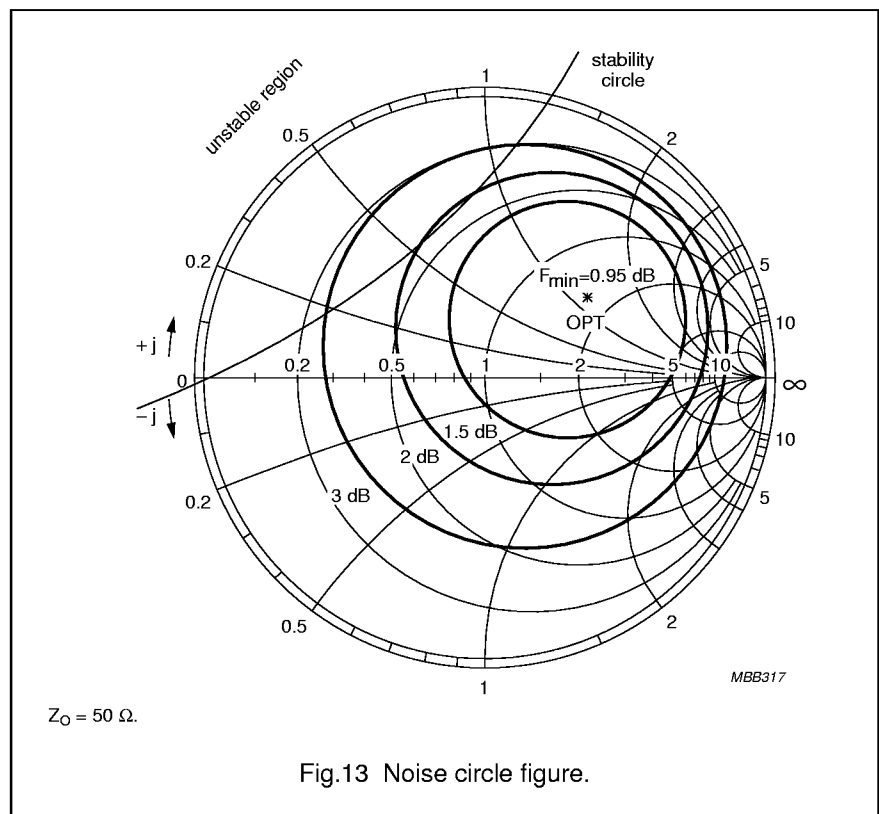


**BFG67/X**

f (MHz)	V <sub>CE</sub> (V)	I <sub>C</sub> (mA)
500	8	5

**Noise Parameters**

F <sub>min</sub> (dB)	Gamma (opt)		R <sub>n</sub> /50
	(mag)	(ang)	
0.95	0.455	33.8	0.288



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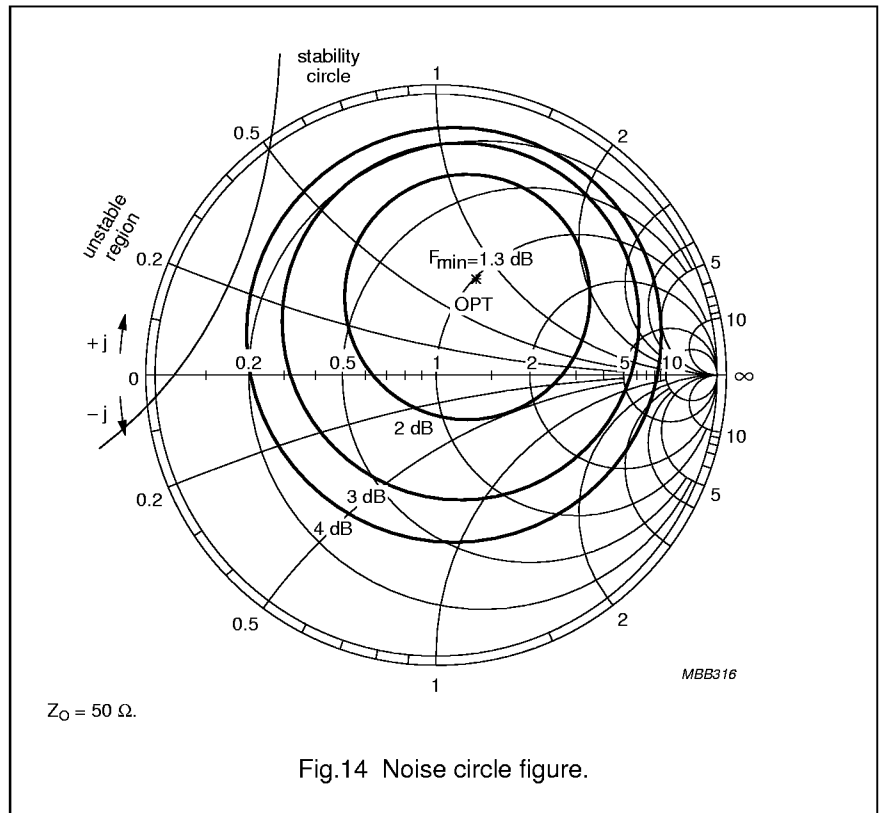
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**BFG67/X**

f (MHz)	V <sub>CE</sub> (V)	I <sub>C</sub> (mA)
1000	8	5

**Noise Parameters**

F <sub>min</sub> (dB)	Gamma (opt)		R <sub>n</sub> /50
	(mag)	(ang)	
1.3	0.375	65.9	0.304



**BFG67/X**

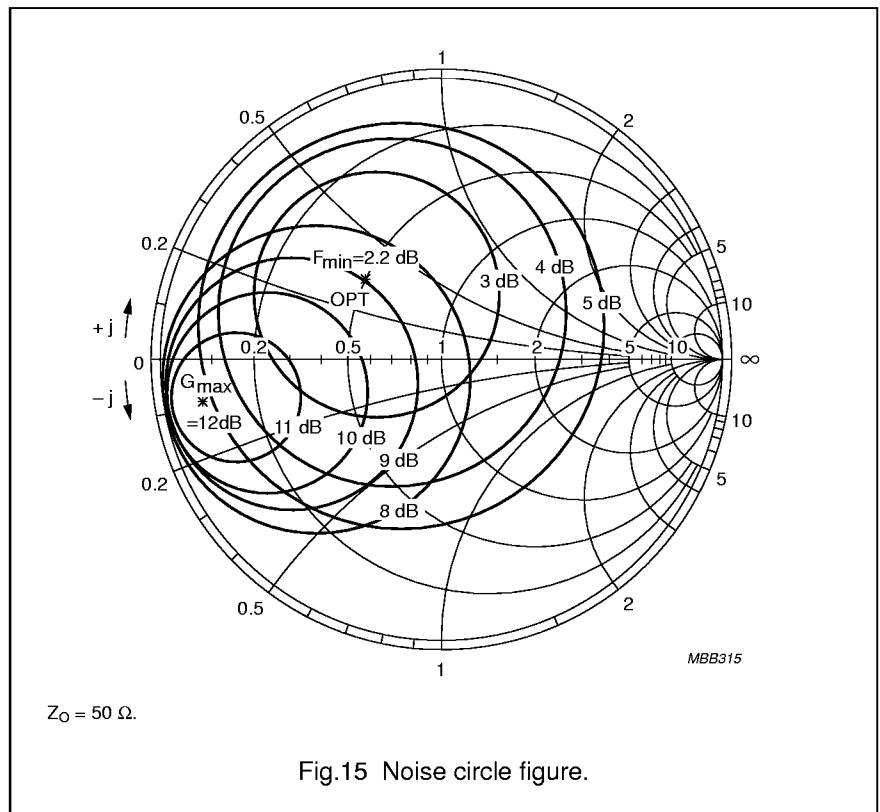
f (MHz)	V <sub>CE</sub> (V)	I <sub>C</sub> (mA)
2000	8	5

**Noise Parameters**

F <sub>min</sub> (dB)	Gamma (opt)		R <sub>n</sub> /50
	(mag)	(ang)	
2.2	0.391	136.5	0.184

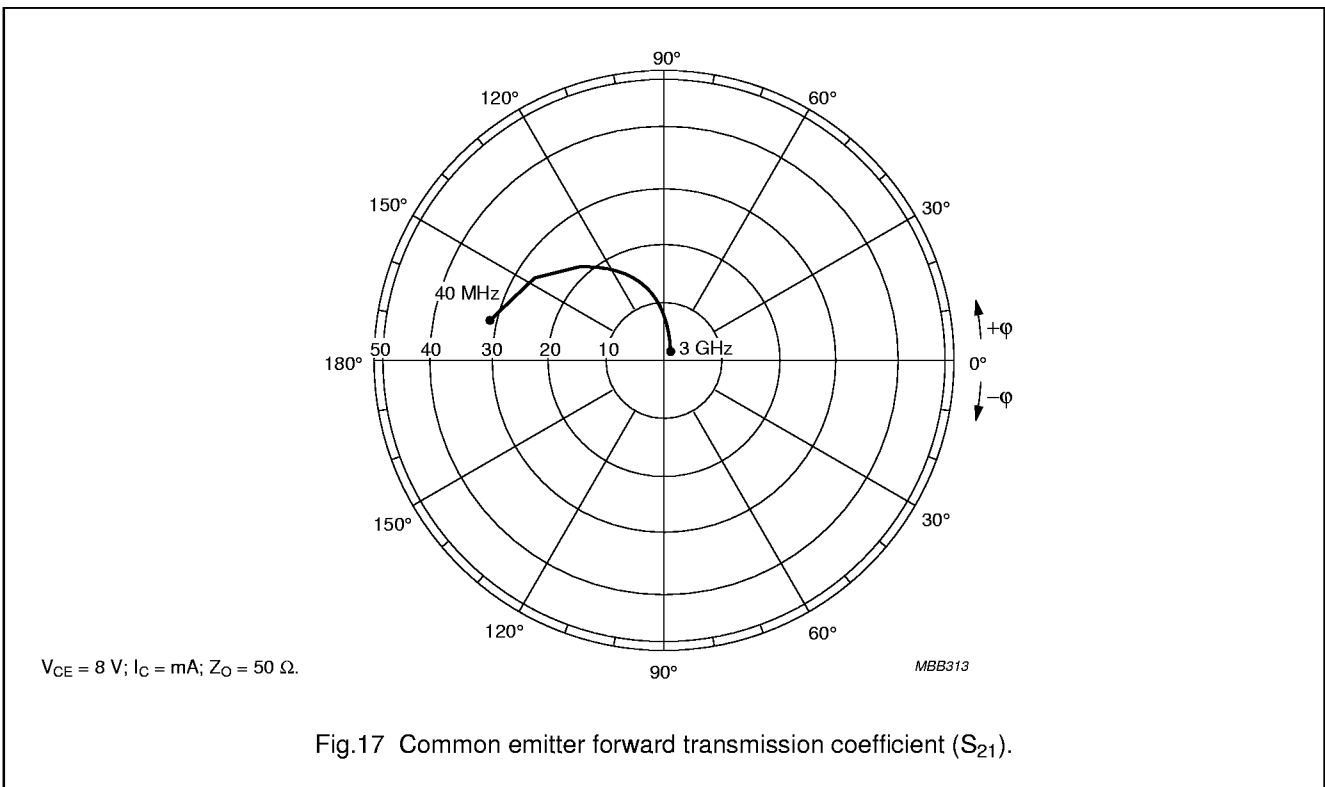
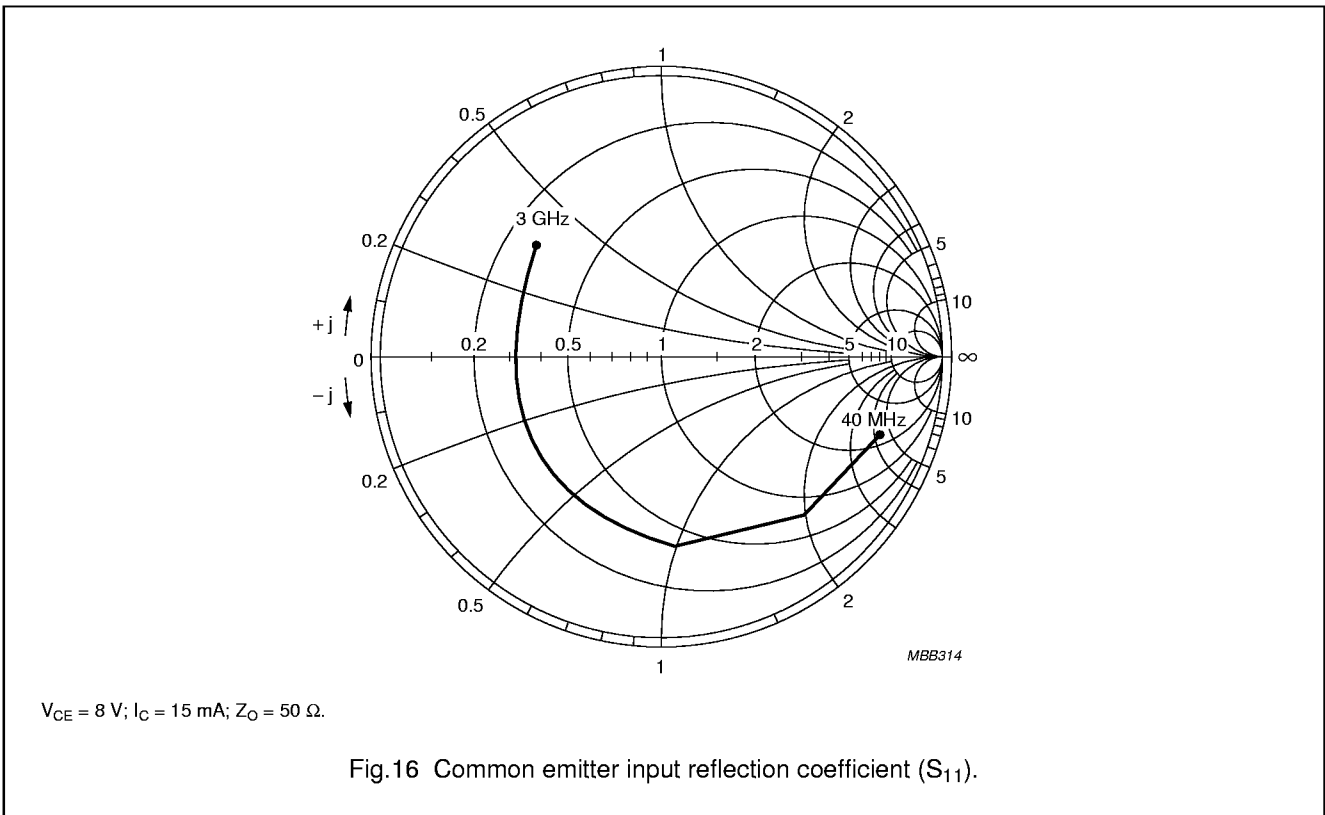
**Average Gain Parameters**

G <sub>MAX</sub> (dB)	Gamma (max)	
	(mag)	(ang)
12	0.839	-170



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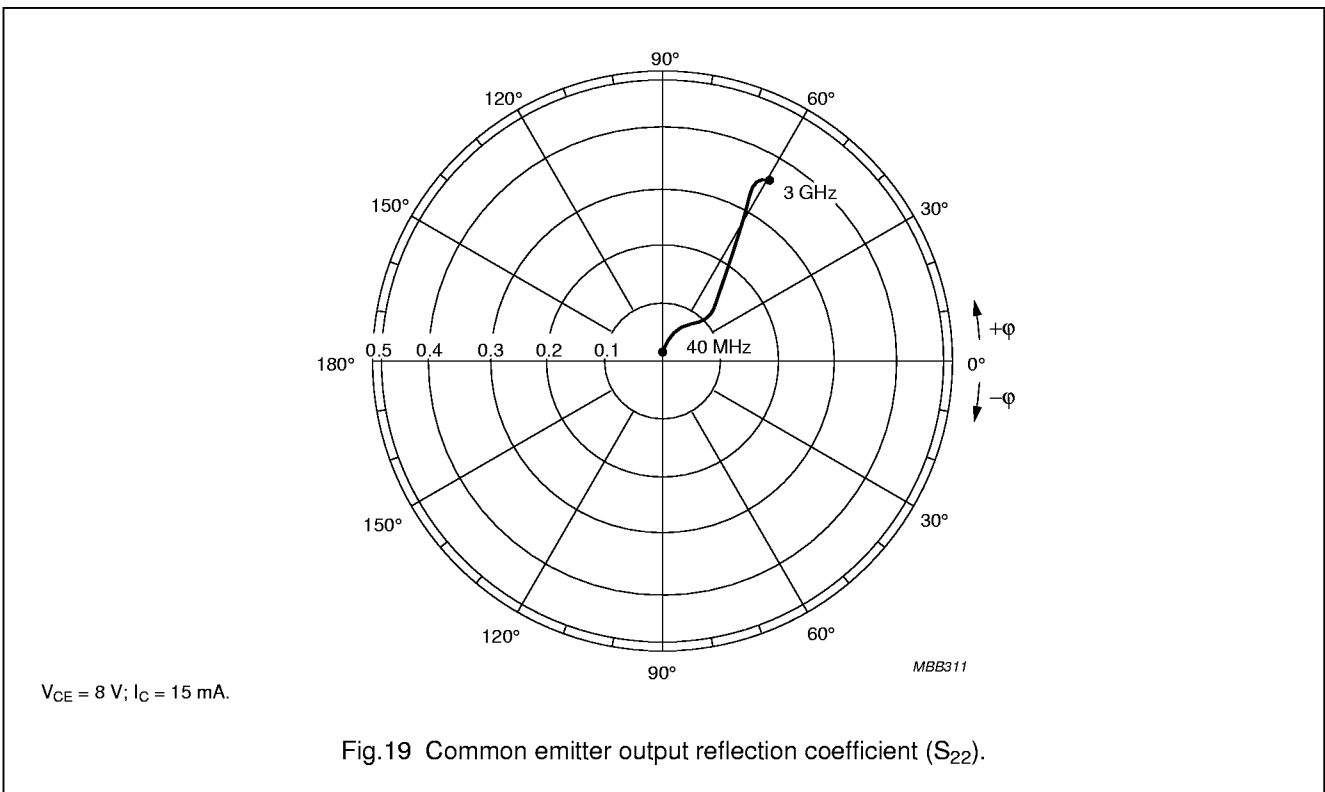
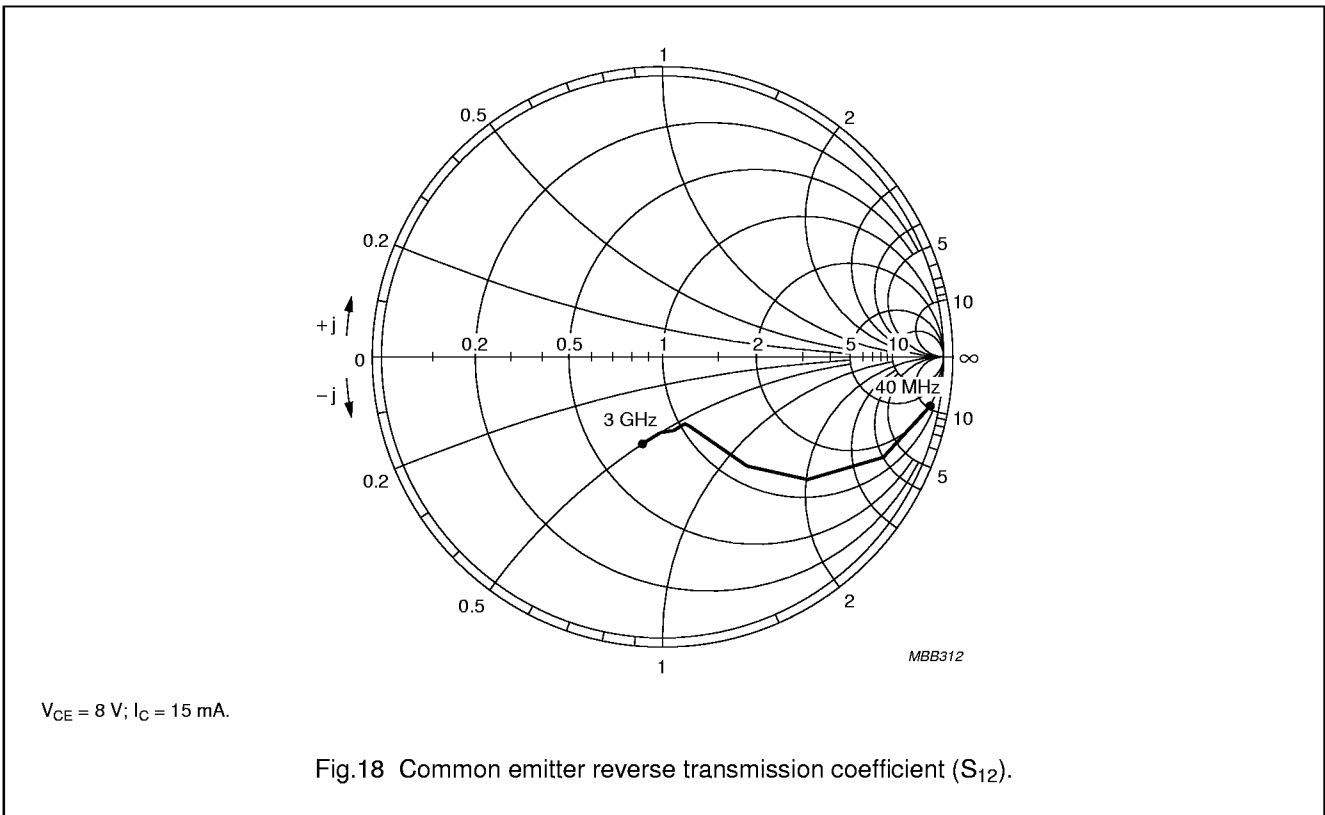
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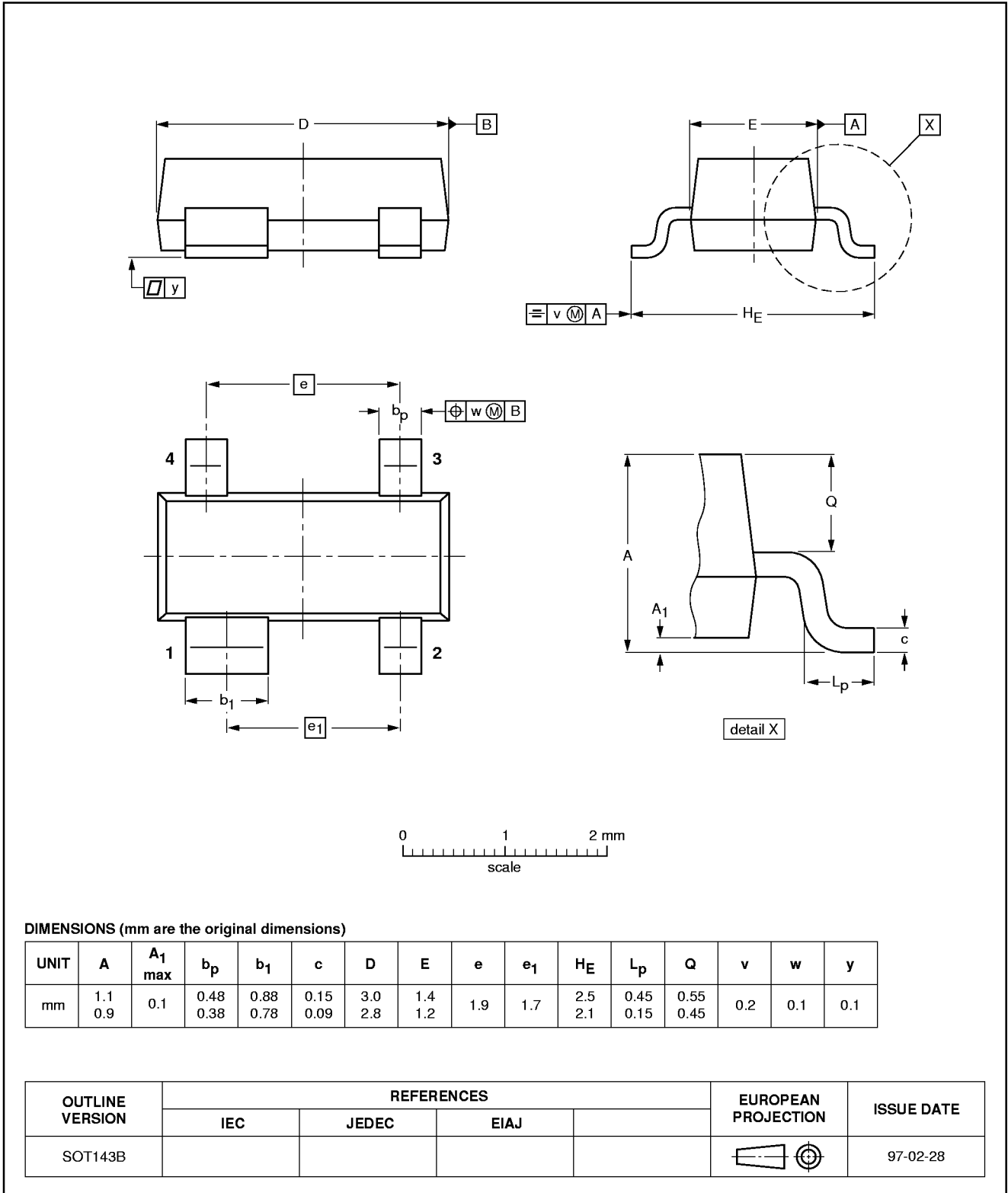
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PACKAGE OUTLINES

Plastic surface mounted package; 4 leads

SOT143B



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Plastic surface mounted package; reverse pinning; 4 leads

SOT143R

